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Texas Instruments Enhanced Plastic Products Reliability Re

(Subject To Attached Disclaimers)

Device Type/Device Family: TPS3307-33MDGNREP
Package Type: 8/DGN
Wafer Fabrication Facility: DL-LIN
Assembly/Test Facility: Hana
Compiled: 12/13

Biased Life Test

Test Method: JESD22-A108
Test Condition: 125°C / 1000 hours or equivalent
Sample Size: 9204
Rejects: 2
Activation Energy (eV): 0.7
Equivalent Device Hours: 3.04E+08
Failure Rate (FIT)*: 10.22

*Derated to +55°C with a 6

Package Related Tests

<u>Description</u>	<u>Condition</u>	<u>Referenced Method</u>	<u>Sample Size</u>
Biased Humidity or HAST	85°C / 85% / 1000 hours or 130°C / 85% / 96 hours	JESD22-A101 JESD22-A110	231
Autoclave	121°C @ 2 atmospheres absolute for 96 hours	JESD22-A102	308
Temperature Cycle	-65°C to +150°C non-biased for 1000 cycles or equivalent	JESD22-A104	770
High Temp Storage	150°C / 1,000 hours	JESD22-A103-A	334

* Preconditioning per JEDEC Std. 2'

Initial Product Qualification

The subject Enhanced Plastic device, device family, and/or package family have passed Texas qualification as follows:

<u>Description</u>	<u>Condition</u>	<u>Referenced Method</u>	<u>Sample</u>
Electrical Characterization	TI Data Sheet	N/A	3 lot(s)/
Electrostatic Discharge Sensitivity	HBM MM CDM	EIA/JESD22-A114 EIA/JESD22-A115 JESD22-C101	3 Units/ N/ N/
Latch-up	Per Technology	EIA/JESD78	6/
Physical Dimensions	TI Data Sheet	EIA/JESD22- B100	N/
Thermal Impedance	Theta-JA on board	EIA/JESD51	Per Pin-I
Bias Life Test	125°C / 1000 hours or equivalent	JESD22-A108	116
Biased Humidity or HAST	85°C / 85% / 1000 hours or 130°C / 85% / 96 hours	JESD22-A101 JESD22-A110	23
Autoclave	121°C @ 2 atmospheres absolute for 96 hours	JESD22-A102	23
Temperature Cycle	-65°C to +150°C non-biased for 1000 cycles or equivalent	JESD22-A104	23
High Temp Storage	150°C / 1,000 hours	JESD22-A103-A	12
Solder Heat	260°C for 10 seconds	JESD22-B106	N/
Solderability	Condition A (steam age for 8 hours)	ANSI/J-STD-002-92	66
Bond Strength	-	ASTM F-459	146
Moisture Sensitivity	Surface Mount Only	J-STD-020-A	44

* Preconditioning per JEDEC Std. 2:

Supplemental Device Characteristics

Master Die: <u>BLBD3307T33A</u>	Assembly Site: <u>Hana</u>
Wafer Fab: <u>DL-LIN</u>	Pin/Package Type: <u>8/DGN</u>
Fab Process: <u>LBC3S</u>	Lead Composition: <u>CU</u>
Fab Technology: <u>LBC3S</u>	Lead Finish: <u>NIPDAU</u>
Die Revision: <u>A</u>	Mount Compound: <u>Ablestik 2200D</u>
Passivation: <u>Nitride</u>	Bond: <u>Au/1.0 mil</u>
Metal 1: <u>TiW/AlSiCu (3.0kA/7.6kA)</u>	Mold Compound: <u>Sumitomo EME-C</u>
Metal 2: <u>TiW/AlSiCu (3.0kA/15.2kA)</u>	Die Thickness: <u>10 mil</u>

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0% Confidence Level

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2, Method A112/A113

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